

STARPOWER

SEMICONDUCTOR

IGBT

GD100TLQ120L3S

1200V/100A 3-level in one-package

General Description

STARPOWER IGBT Power Module provides ultra low conduction loss as well as short circuit ruggedness. They are designed for the applications such as 3-level-application.

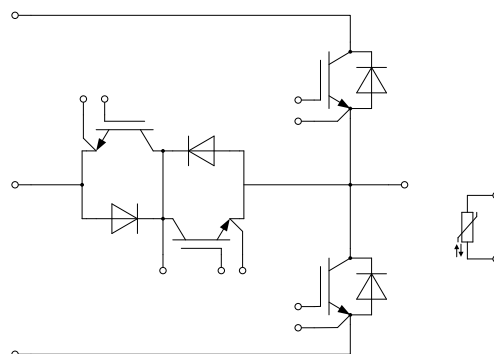
Features

- Low $V_{CE(sat)}$ Trench IGBT technology
- Low switching loss
- 10 μ s short circuit capability
- $V_{CE(sat)}$ with positive temperature coefficient
- Maximum junction temperature 175 $^{\circ}$ C
- Fast & soft reverse recovery anti-parallel FWD
- Low inductance case
- Isolated heatsink using DBC technology

Typical Applications

- Solar power
- UPS
- 3-level-application

Equivalent Circuit Schematic



Absolute Maximum Ratings $T_C=25^{\circ}\text{C}$ unless otherwise noted**T1,T4 IGBT**

Symbol	Description	Value	Unit
V_{CES}	Collector-Emitter Voltage	1200	V
V_{GES}	Gate-Emitter Voltage	± 20	V
I_C	Collector Current @ $T_C=100^{\circ}\text{C}$	100	A
I_{CM}	Pulsed Collector Current $t_p=1\text{ms}$	200	A
P_D	Maximum Power Dissipation @ $T_j=175^{\circ}\text{C}$	765	W

D1,D4 Diode

Symbol	Description	Value	Unit
V_{RRM}	Repetitive Peak Reverse Voltage	1200	V
I_F	Diode Continuous Forward Current	35	A
I_{FM}	Diode Maximum Forward Current $t_p=1\text{ms}$	150	A

T2,T3 IGBT

Symbol	Description	Value	Unit
V_{CES}	Collector-Emitter Voltage	650	V
V_{GES}	Gate-Emitter Voltage	± 20	V
I_C	Collector Current @ $T_C=100^{\circ}\text{C}$	50	A
I_{CM}	Pulsed Collector Current $t_p=1\text{ms}$	100	A
P_D	Maximum Power Dissipation @ $T_j=175^{\circ}\text{C}$	271	W

D2,D3 Diode

Symbol	Description	Value	Unit
V_{RRM}	Repetitive Peak Reverse Voltage	650	V
I_F	Diode Continuous Forward Current	100	A
I_{FM}	Diode Maximum Forward Current $t_p=1\text{ms}$	200	A

Module

Symbol	Description	Value	Unit
T_{jmax}	Maximum Junction Temperature	175	$^{\circ}\text{C}$
T_{jop}	Operating Junction Temperature	-40 to +150	$^{\circ}\text{C}$
T_{STG}	Storage Temperature Range	-40 to +125	$^{\circ}\text{C}$
V_{ISO}	Isolation Voltage RMS, $f=50\text{Hz}, t=1\text{min}$	2500	V

T1,T4 IGBT Characteristics $T_C=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage	$I_C=50\text{A}, V_{GE}=15\text{V}, T_j=25^\circ\text{C}$		1.40	1.95	V
		$I_C=50\text{A}, V_{GE}=15\text{V}, T_j=125^\circ\text{C}$		1.65		
		$I_C=50\text{A}, V_{GE}=15\text{V}, T_j=150^\circ\text{C}$		1.70		
$V_{GE(th)}$	Gate-Emitter Threshold Voltage	$I_C=2.50\text{mA}, V_{CE}=V_{GE}, T_j=25^\circ\text{C}$	5.2	6.0	6.8	V
I_{CES}	Collector Cut-Off Current	$V_{CE}=V_{CES}, V_{GE}=0\text{V}, T_j=25^\circ\text{C}$			1.0	mA
I_{GES}	Gate-Emitter Leakage Current	$V_{GE}=V_{GES}, V_{CE}=0\text{V}, T_j=25^\circ\text{C}$			100	nA
R_{Gint}	Internal Gate Resistance			7.5		Ω
C_{ies}	Input Capacitance	$V_{CE}=25\text{V}, f=1\text{MHz}, V_{GE}=0\text{V}$		10.4		nF
C_{res}	Reverse Transfer Capacitance			0.29		nF
Q_G	Gate Charge	$V_{GE}=-15\dots+15\text{V}$		0.78		μC
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=400\text{V}, I_C=50\text{A}, R_G=1.1\Omega, V_{GE}=\pm 15\text{V}, T_j=25^\circ\text{C}$		132		ns
t_r	Rise Time			20		ns
$t_{d(off)}$	Turn-Off Delay Time			330		ns
t_f	Fall Time			33		ns
E_{on}	Turn-On Switching Loss			1.06		mJ
E_{off}	Turn-Off Switching Loss			1.78		mJ
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=400\text{V}, I_C=50\text{A}, R_G=1.1\Omega, V_{GE}=\pm 15\text{V}, T_j=125^\circ\text{C}$		140		ns
t_r	Rise Time			29		ns
$t_{d(off)}$	Turn-Off Delay Time			418		ns
t_f	Fall Time			67		ns
E_{on}	Turn-On Switching Loss			1.67		mJ
E_{off}	Turn-Off Switching Loss			2.86		mJ
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=400\text{V}, I_C=50\text{A}, R_G=1.1\Omega, V_{GE}=\pm 15\text{V}, T_j=150^\circ\text{C}$		146		ns
t_r	Rise Time			30		ns
$t_{d(off)}$	Turn-Off Delay Time			440		ns
t_f	Fall Time			72		ns
E_{on}	Turn-On Switching Loss			1.79		mJ
E_{off}	Turn-Off Switching Loss			3.25		mJ
I_{SC}	SC Data	$t_p \leq 10\mu\text{s}, V_{GE}=15\text{V}, T_j=150^\circ\text{C}, V_{CC}=800\text{V}, V_{CEM} \leq 1200\text{V}$		400		A

D1,D4 Diode Characteristics $T_C=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V_F	Diode Forward Voltage	$I_F=35\text{A}, V_{GE}=0\text{V}, T_j=25^{\circ}\text{C}$		2.00	2.45	V
		$I_F=35\text{A}, V_{GE}=0\text{V}, T_j=125^{\circ}\text{C}$		1.70		
		$I_F=35\text{A}, V_{GE}=0\text{V}, T_j=150^{\circ}\text{C}$		1.65		
Q_r	Recovered Charge	$V_R=400\text{V}, I_F=35\text{A},$ $-di/dt=2400\text{A}/\mu\text{s}, V_{GE}=-15\text{V}$ $T_j=25^{\circ}\text{C}$		2.4		μC
I_{RM}	Peak Reverse Recovery Current			70		A
E_{rec}	Reverse Recovery Energy			0.70		mJ
Q_r	Recovered Charge	$V_R=400\text{V}, I_F=35\text{A},$ $-di/dt=2400\text{A}/\mu\text{s}, V_{GE}=-15\text{V}$ $T_j=125^{\circ}\text{C}$		5.7		μC
I_{RM}	Peak Reverse Recovery Current			85		A
E_{rec}	Reverse Recovery Energy			1.75		mJ
Q_r	Recovered Charge	$V_R=400\text{V}, I_F=35\text{A},$ $-di/dt=2400\text{A}/\mu\text{s}, V_{GE}=-15\text{V}$ $T_j=150^{\circ}\text{C}$		7.0		μC
I_{RM}	Peak Reverse Recovery Current			90		A
E_{rec}	Reverse Recovery Energy			2.15		mJ

T2,T3 IGBT Characteristics $T_C=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage	$I_C=50\text{A}, V_{GE}=15\text{V}, T_j=25^\circ\text{C}$		1.45	1.90	V
		$I_C=50\text{A}, V_{GE}=15\text{V}, T_j=125^\circ\text{C}$		1.60		
		$I_C=50\text{A}, V_{GE}=15\text{V}, T_j=150^\circ\text{C}$		1.70		
$V_{GE(th)}$	Gate-Emitter Threshold Voltage	$I_C=0.80\text{mA}, V_{CE}=V_{GE}, T_j=25^\circ\text{C}$	5.1	5.8	6.5	V
I_{CES}	Collector Cut-Off Current	$V_{CE}=V_{CES}, V_{GE}=0\text{V}, T_j=25^\circ\text{C}$			1.0	mA
I_{GES}	Gate-Emitter Leakage Current	$V_{GE}=V_{GES}, V_{CE}=0\text{V}, T_j=25^\circ\text{C}$			400	nA
R_{Gint}	Internal Gate Resistance			0		Ω
C_{ies}	Input Capacitance	$V_{CE}=25\text{V}, f=1\text{MHz}, V_{GE}=0\text{V}$		5.80		nF
C_{res}	Reverse Transfer Capacitance			0.11		nF
Q_G	Gate Charge	$V_{GE}=-15\dots+15\text{V}$		0.35		μC
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=400\text{V}, I_C=50\text{A}, R_G=8.2\Omega, V_{GE}=\pm 15\text{V}, T_j=25^\circ\text{C}$		20		ns
t_r	Rise Time			14		ns
$t_{d(off)}$	Turn-Off Delay Time			152		ns
t_f	Fall Time			26		ns
E_{on}	Turn-On Switching Loss			0.88		mJ
E_{off}	Turn-Off Switching Loss			1.20		mJ
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=400\text{V}, I_C=50\text{A}, R_G=8.2\Omega, V_{GE}=\pm 15\text{V}, T_j=125^\circ\text{C}$		20		ns
t_r	Rise Time			17		ns
$t_{d(off)}$	Turn-Off Delay Time			176		ns
t_f	Fall Time			40		ns
E_{on}	Turn-On Switching Loss			1.40		mJ
E_{off}	Turn-Off Switching Loss			1.64		mJ
$t_{d(on)}$	Turn-On Delay Time	$V_{CC}=400\text{V}, I_C=50\text{A}, R_G=8.2\Omega, V_{GE}=\pm 15\text{V}, T_j=150^\circ\text{C}$		20		ns
t_r	Rise Time			18		ns
$t_{d(off)}$	Turn-Off Delay Time			200		ns
t_f	Fall Time			44		ns
E_{on}	Turn-On Switching Loss			1.52		mJ
E_{off}	Turn-Off Switching Loss			1.76		mJ
I_{SC}	SC Data	$t_p \leq 6\mu\text{s}, V_{GE}=15\text{V}, T_j=150^\circ\text{C}, V_{CC}=360\text{V}, V_{CEM} \leq 1200\text{V}$		250		A

D2,D3 Diode Characteristics $T_C=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit		
V_F	Diode Forward Voltage	$I_F=50\text{A}, V_{GE}=0\text{V}, T_j=25^\circ\text{C}$		1.35	1.80	V		
		$I_F=50\text{A}, V_{GE}=0\text{V}, T_j=125^\circ\text{C}$		1.30				
		$I_F=50\text{A}, V_{GE}=0\text{V}, T_j=150^\circ\text{C}$		1.25				
Q_r	Recovered Charge	$V_R=400\text{V}, I_F=50\text{A},$ $-di/dt=2200\text{A}/\mu\text{s}, V_{GE}=-15\text{V}$ $T_j=25^\circ\text{C}$		2.09		μC		
I_{RM}	Peak Reverse Recovery Current			57		A		
E_{rec}	Reverse Recovery Energy			0.50		mJ		
Q_r	Recovered Charge	$V_R=400\text{V}, I_F=50\text{A},$ $-di/dt=2200\text{A}/\mu\text{s}, V_{GE}=-15\text{V}$ $T_j=125^\circ\text{C}$		3.96		μC		
			I_{RM}	Peak Reverse Recovery Current		63		A
			E_{rec}	Reverse Recovery Energy		0.83		mJ
Q_r	Recovered Charge	$V_R=400\text{V}, I_F=50\text{A},$ $-di/dt=2200\text{A}/\mu\text{s}, V_{GE}=-15\text{V}$ $T_j=150^\circ\text{C}$		4.51		μC		
			I_{RM}	Peak Reverse Recovery Current		65		A
			E_{rec}	Reverse Recovery Energy		0.94		mJ

NTC Characteristics $T_C=25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
R_{25}	Rated Resistance			5.0		$\text{k}\Omega$
$\Delta R/R$	Deviation of R_{100}	$T_C=100^\circ\text{C}, R_{100}=493.3\Omega$	-5		5	%
P_{25}	Power Dissipation				20.0	mW
$B_{25/50}$	B-value	$R_2=R_{25}\exp[B_{25/50}(1/T_2-1/(298.15\text{K}))]$		3375		K
$B_{25/80}$	B-value	$R_2=R_{25}\exp[B_{25/80}(1/T_2-1/(298.15\text{K}))]$		3411		K
$B_{25/100}$	B-value	$R_2=R_{25}\exp[B_{25/100}(1/T_2-1/(298.15\text{K}))]$		3433		K

Module Characteristics $T_c=25^{\circ}\text{C}$ unless otherwise noted

Symbol	Parameter	Min.	Typ.	Max.	Unit
R_{thJC}	Junction-to-Case (per T1,T4 IGBT)		0.178	0.196	K/W
	Junction-to-Case (per D1,D4 Diode)		0.496	0.546	
	Junction-to-Case (per T2,T3 IGBT)		0.503	0.553	
	Junction-to-Case (per D2,D3 Diode)		0.486	0.535	
R_{thCH}	Case-to-Heatsink (per T1,T4 IGBT)		0.154		K/W
	Case-to-Heatsink (per D1,D4 Diode)		0.429		
	Case-to-Heatsink (per T2,T3 IGBT)		0.434		
	Case-to-Heatsink (per D2,D3 Diode)		0.420		
	Case-to-Heatsink (per Module)		0.037		
F	Mounting Force Per Clamp	40		80	K/W
G	Weight of Module		39		g

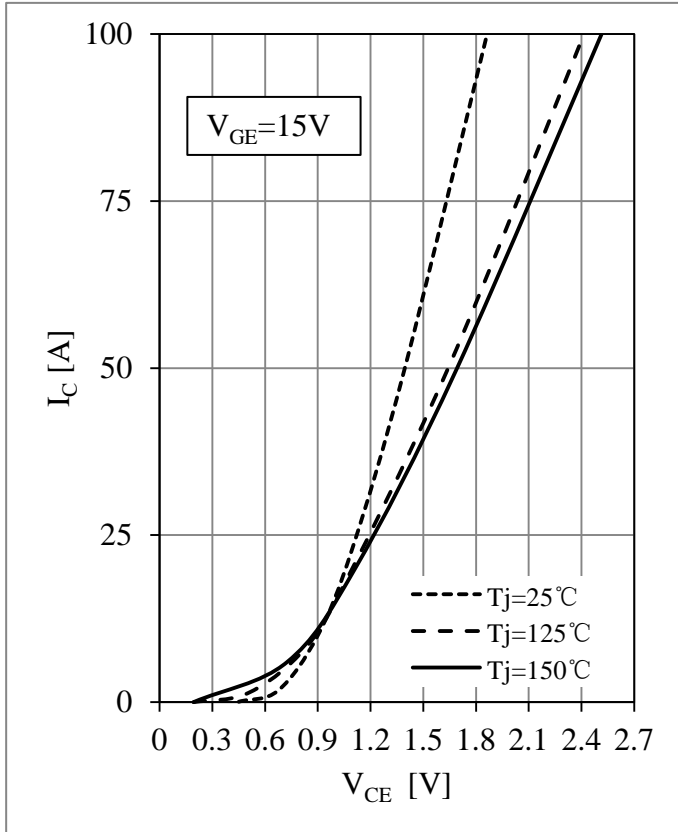


Fig 1. T1,T4 IGBT Output Characteristics

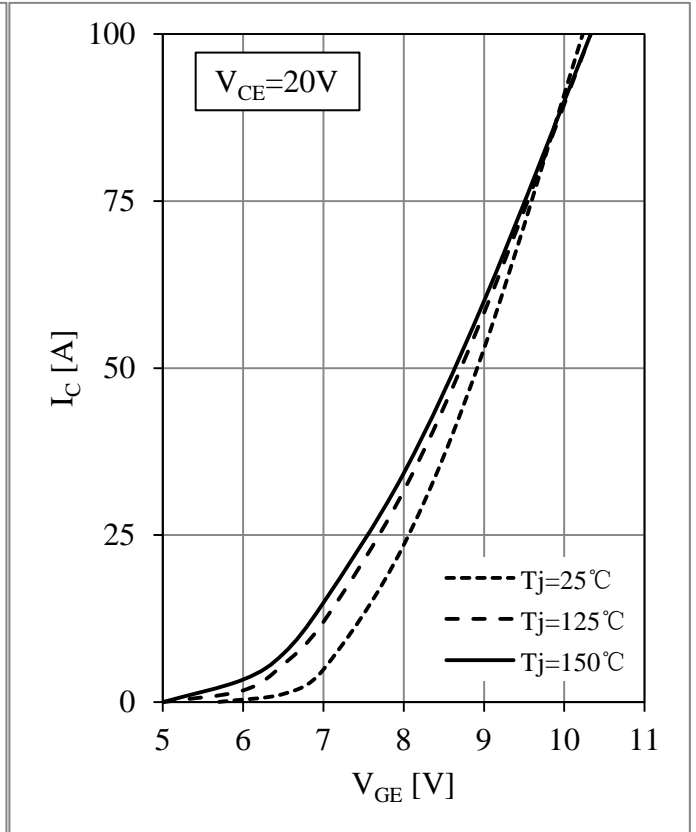


Fig 2. T1,T4 IGBT Transfer Characteristics

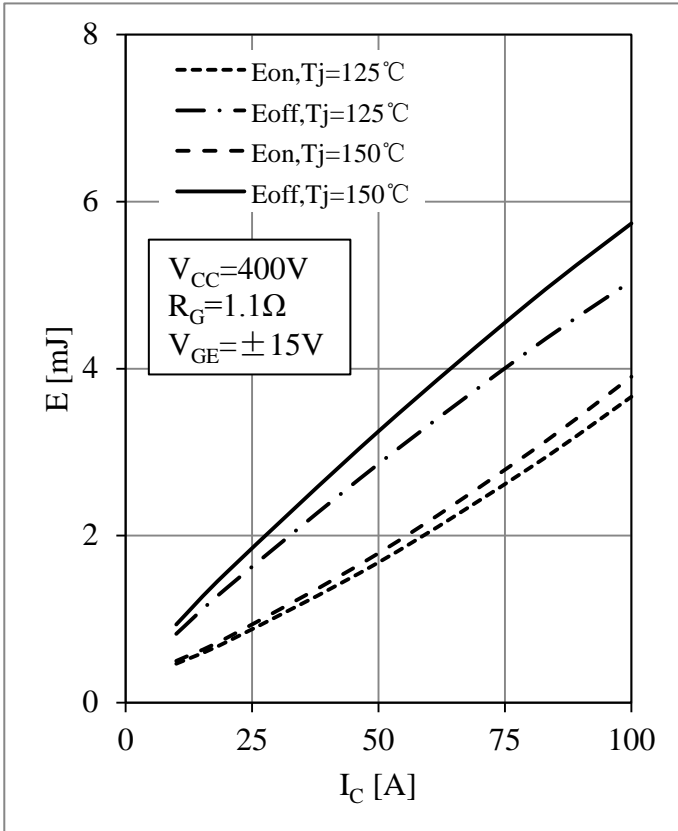


Fig 3. T1,T4 IGBT Switching Loss vs. I_C

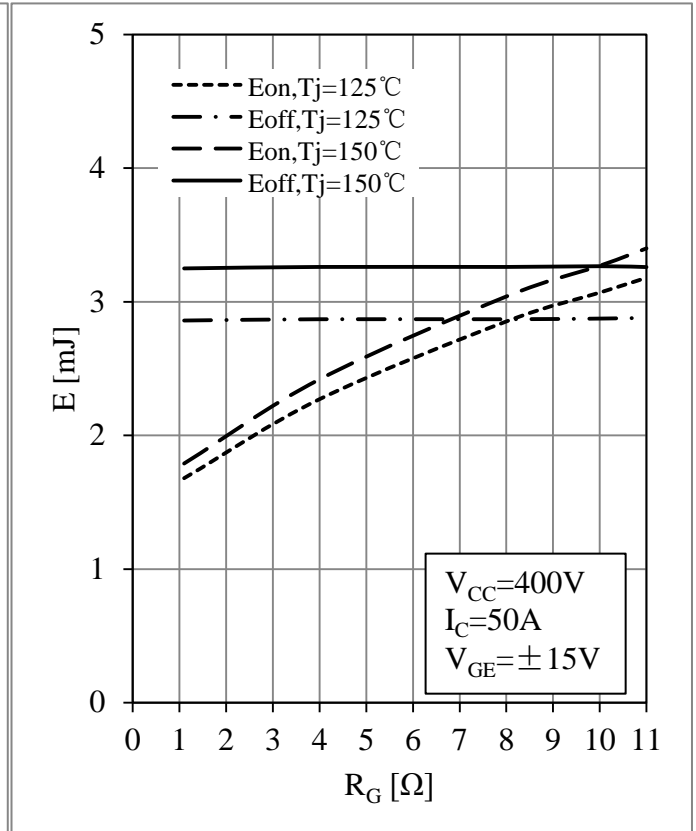


Fig 4. T1,T4 IGBT Switching Loss vs. R_G

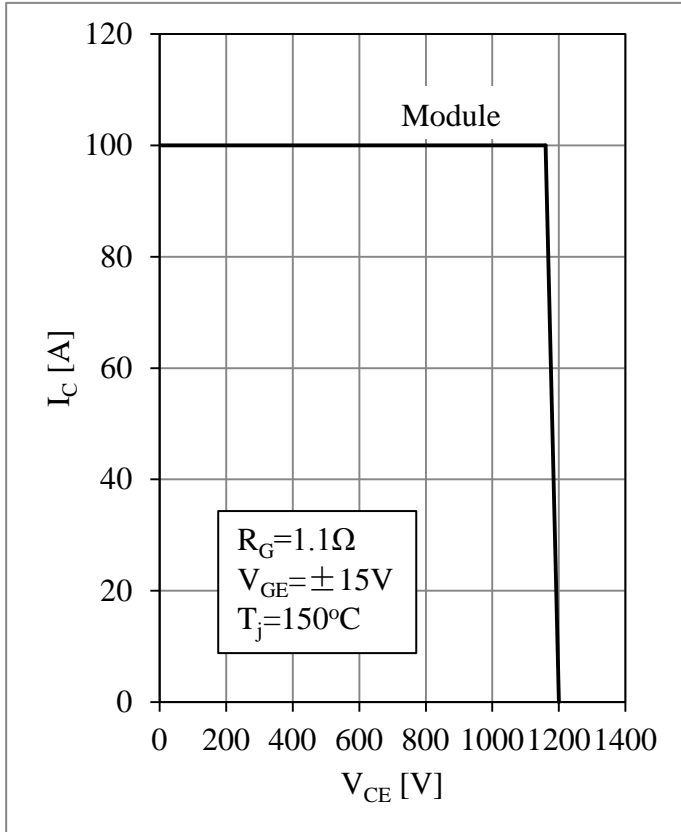


Fig 5. T1,T4 RBSOA

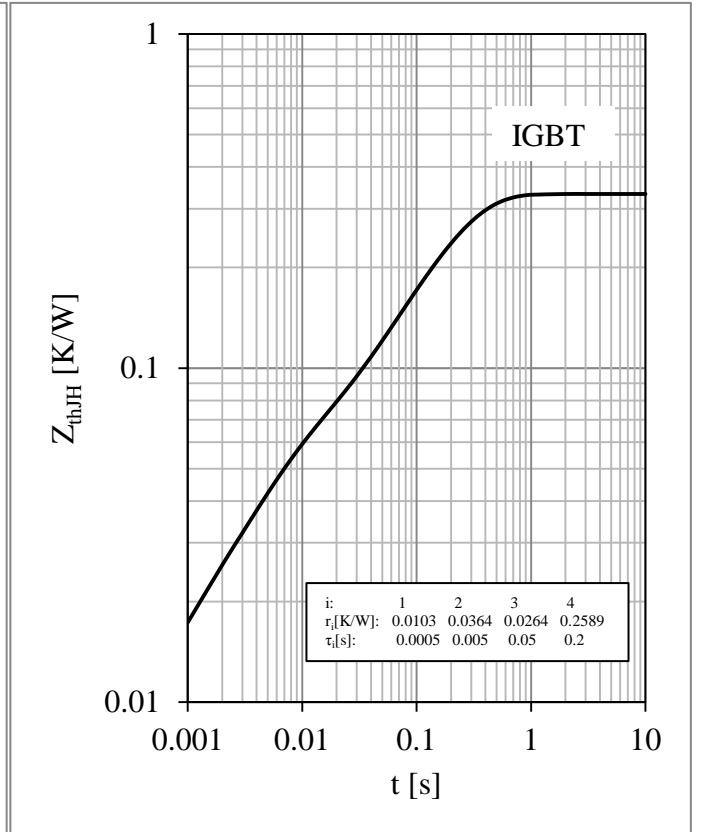


Fig 6. T1,T4 IGBT Transient Thermal Impedance

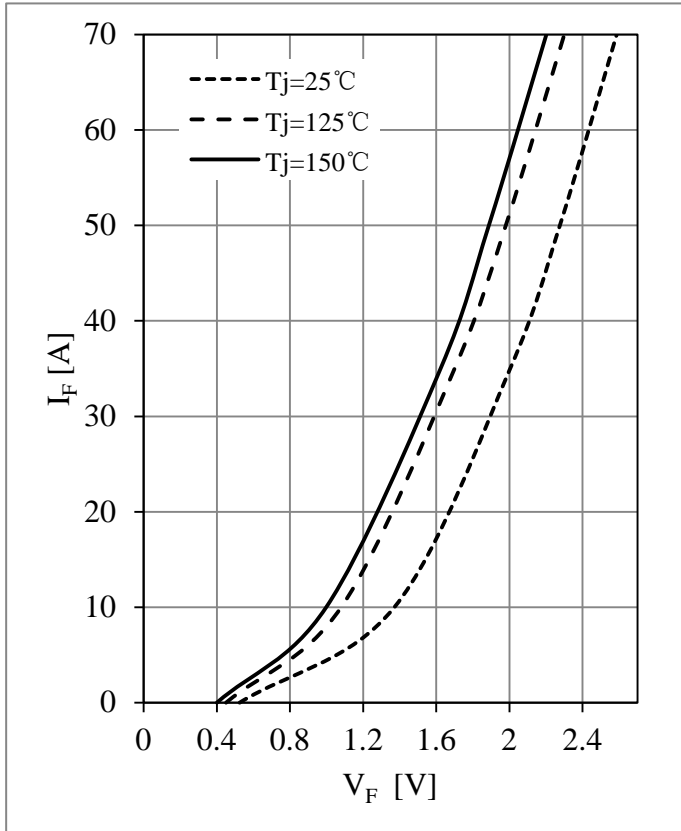


Fig 7. D1,D4 Diode Forward Characteristics

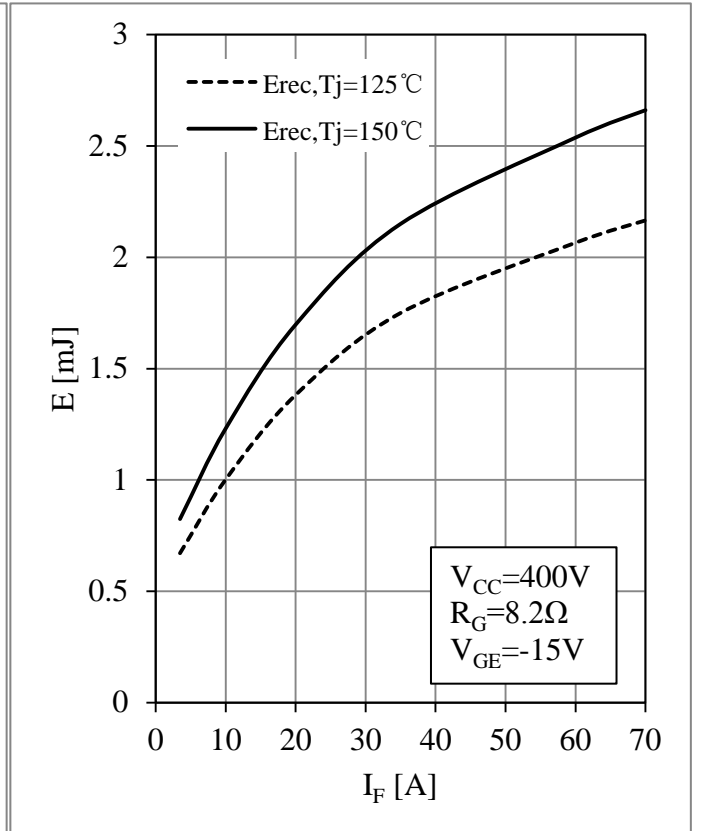


Fig 8. D1,D4 Diode Switching Loss vs. I_F

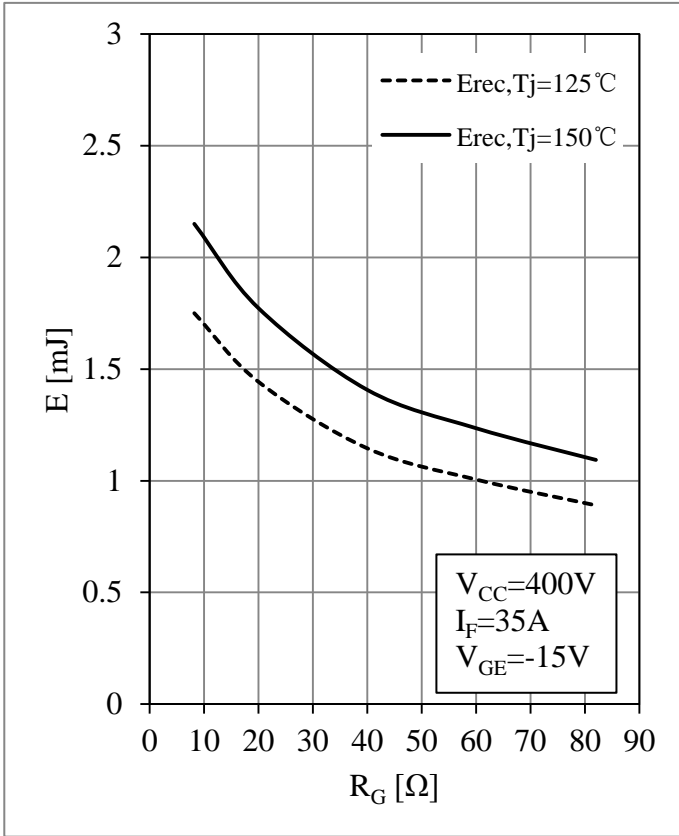


Fig 9. D1,D4 Diode Switching Loss vs. R_G

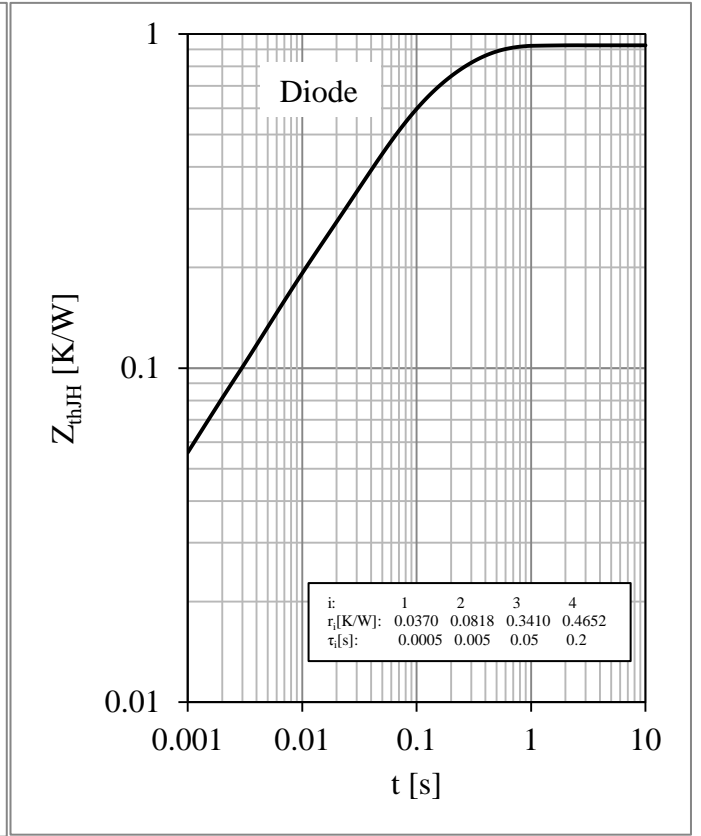


Fig 10. D1,D4 Diode Transient Thermal Impedance

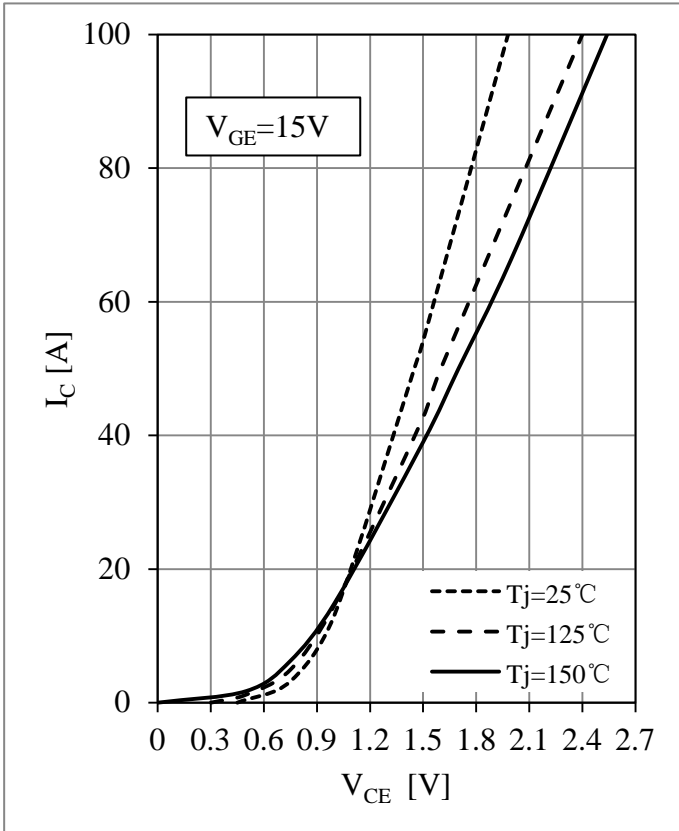


Fig 11. T2,T3 IGBT Output Characteristics

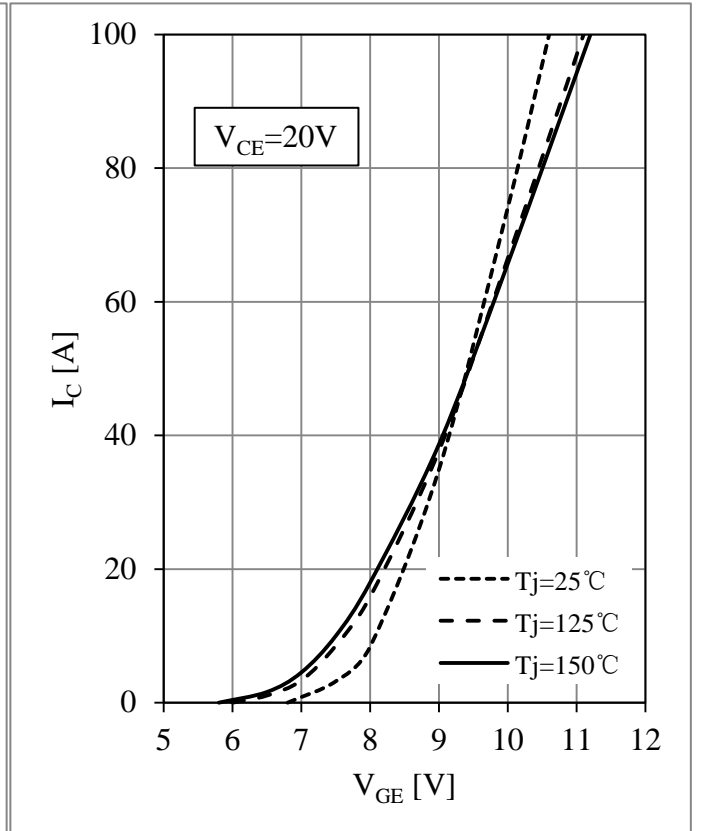


Fig 12. T2,T3 IGBT Transfer Characteristics

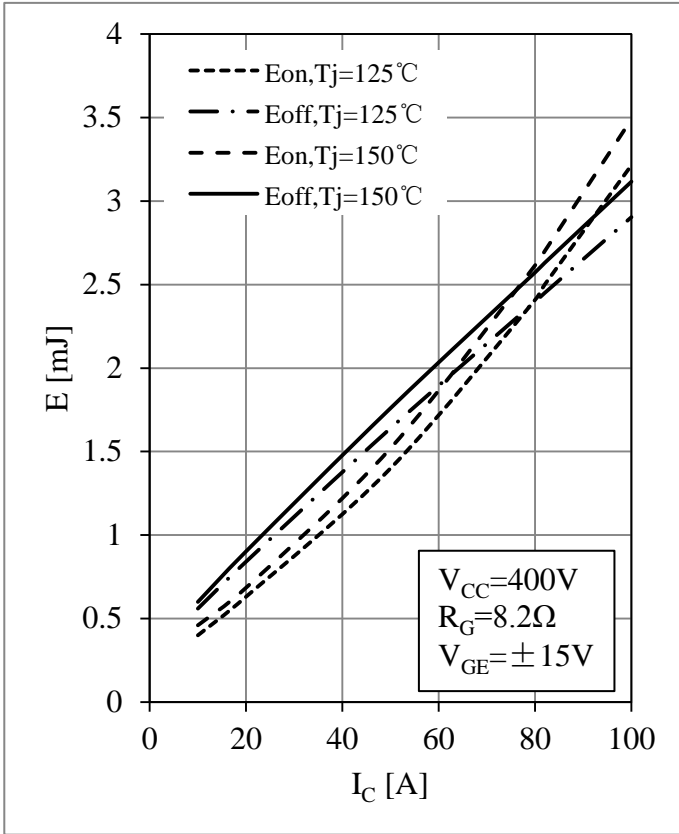


Fig 13. T2,T3 IGBT Switching Loss vs. I_C

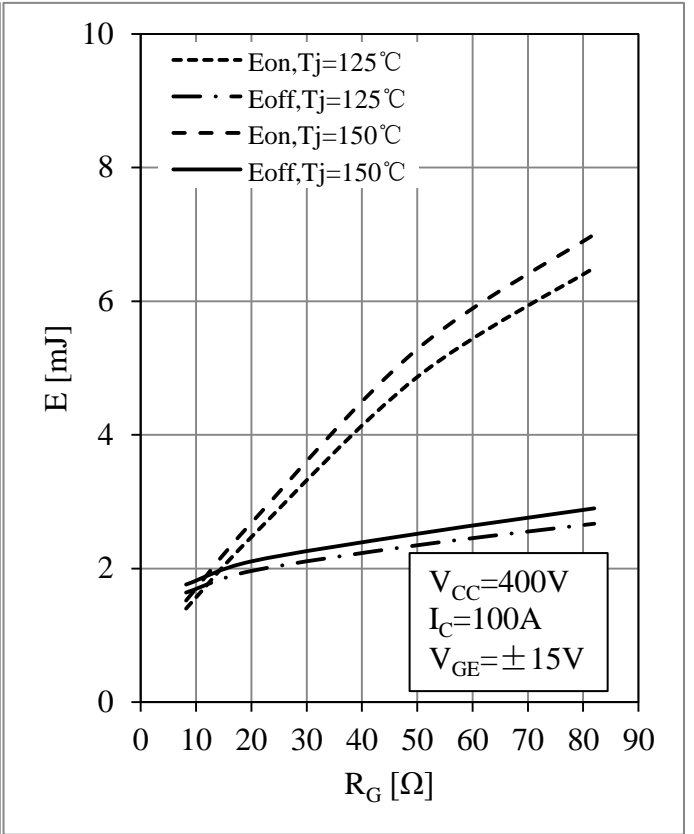


Fig 14. T2,T3 IGBT Switching Loss vs. R_G

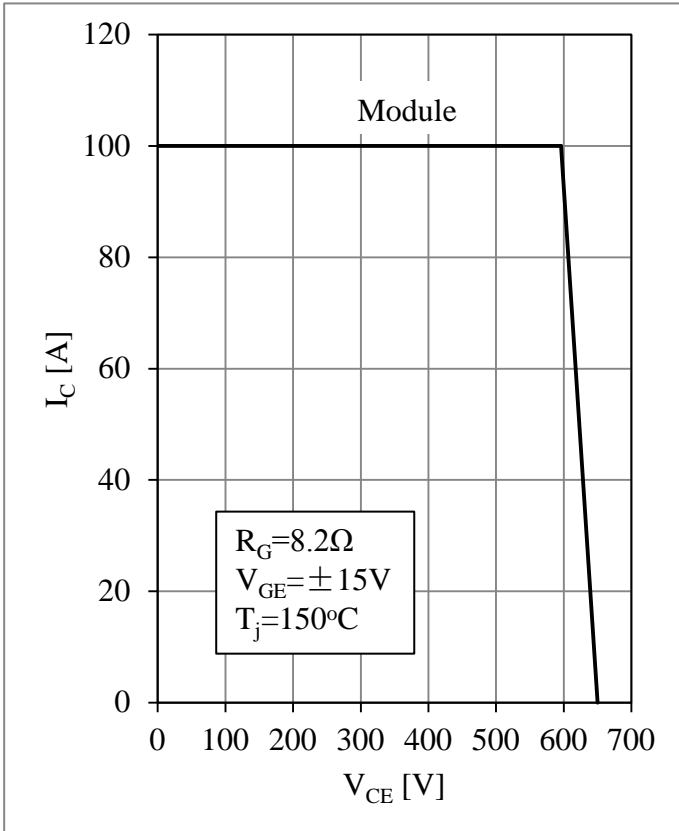


Fig 15. T2,T3 RBSOA

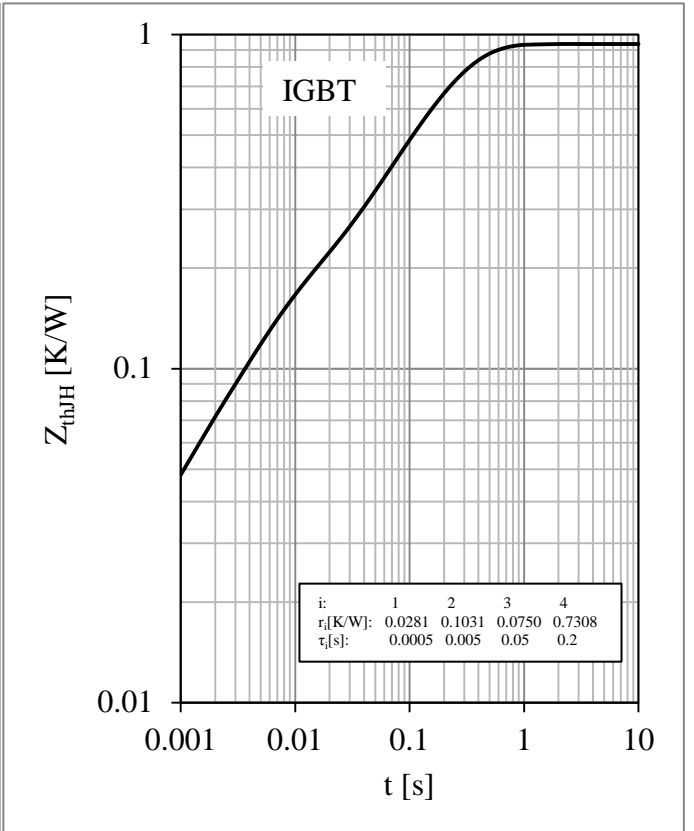


Fig 16. T2,T3 IGBT Transient Thermal Impedance

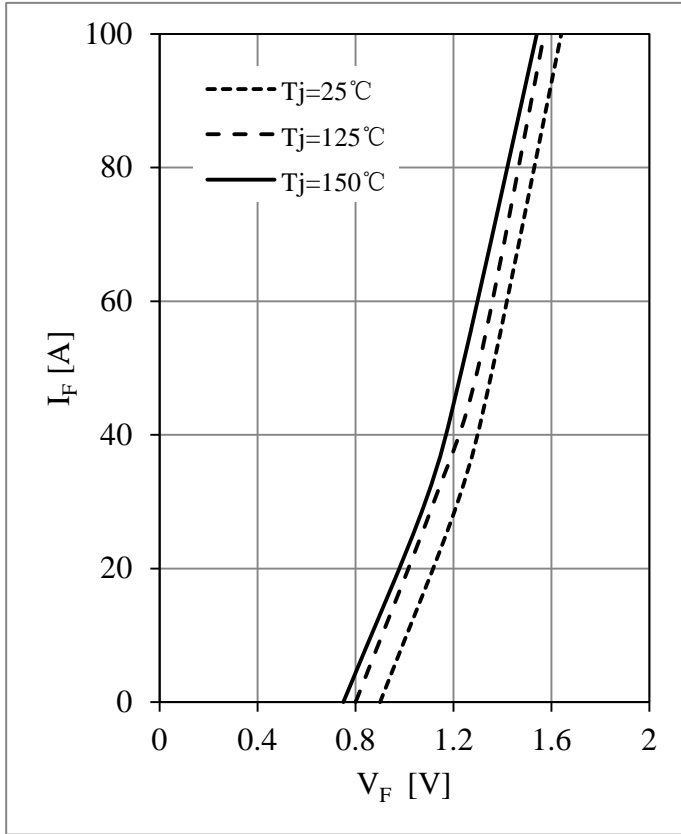


Fig 17. D2,D3 Diode Forward Characteristics

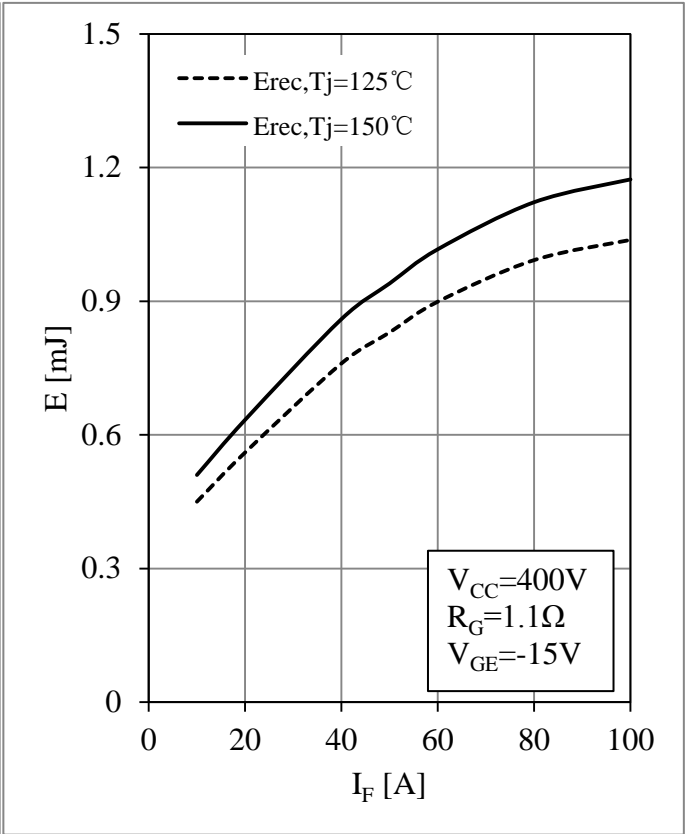


Fig 18. D2,D3 Diode Switching Loss vs. I_F

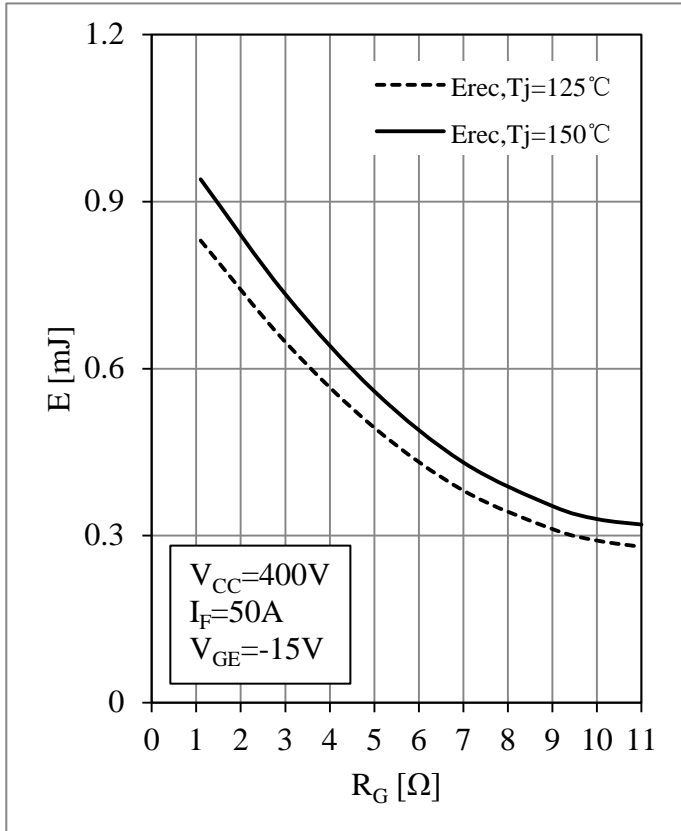


Fig 19. D2,D3 Diode Switching Loss vs. R_G

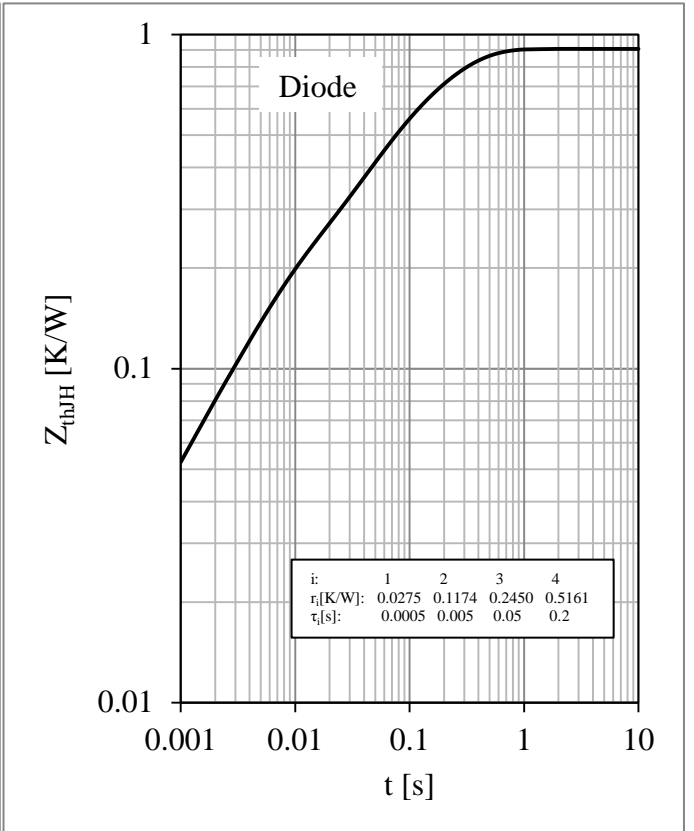


Fig 20. D2,D3 Diode Transient Thermal Impedance

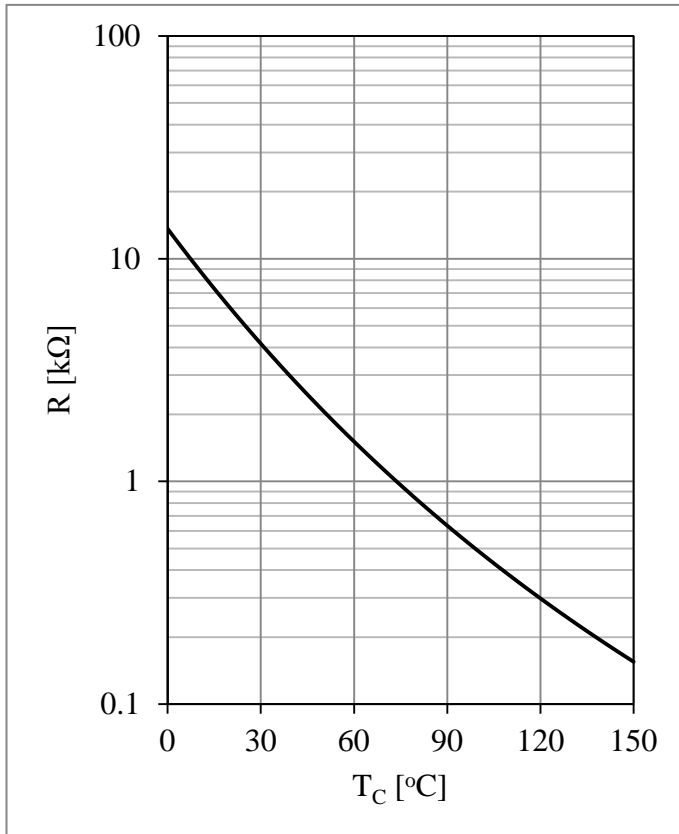
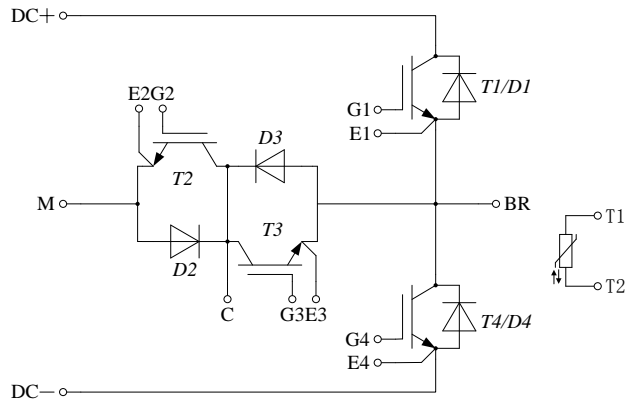


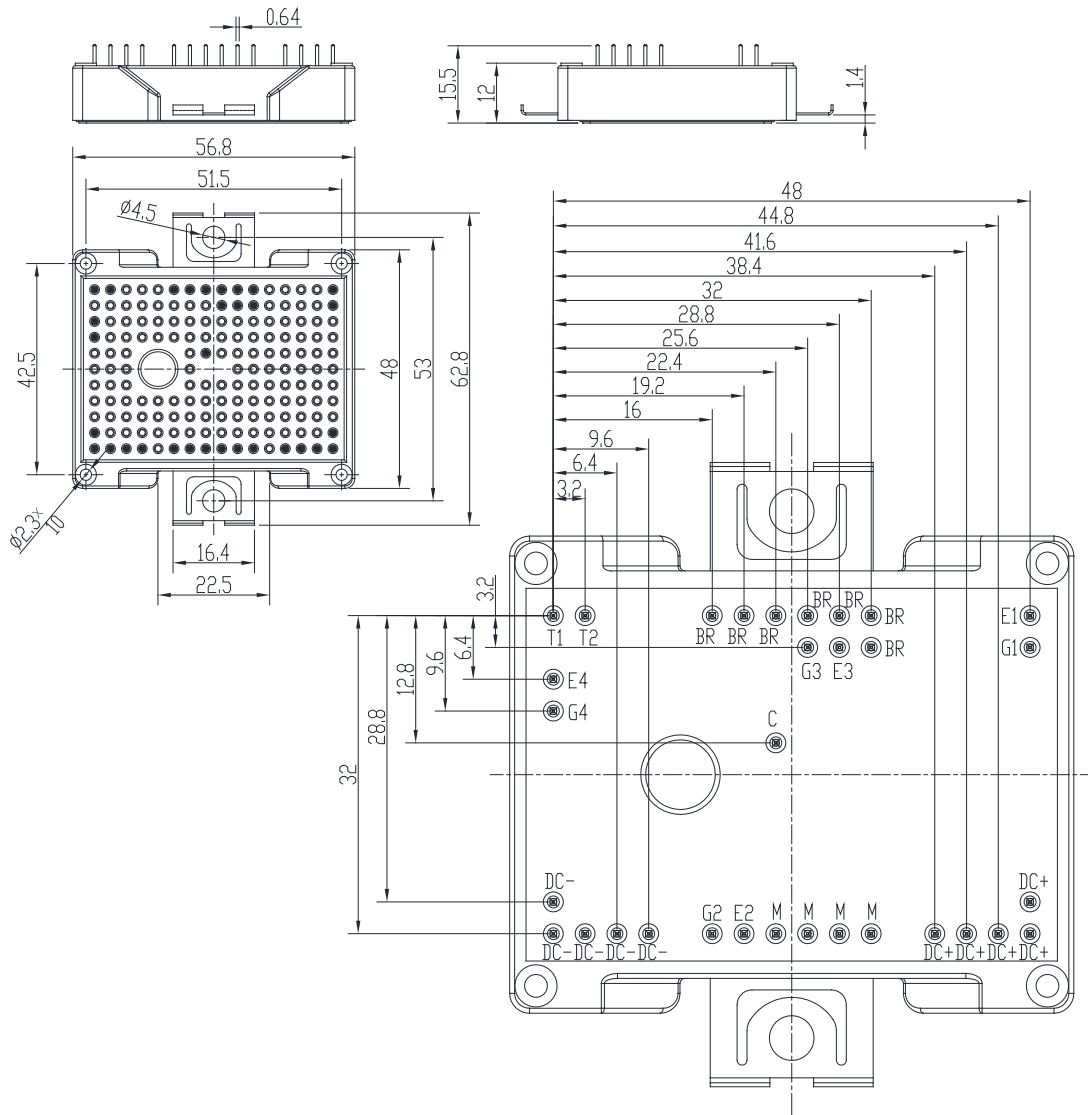
Fig 21. NTC Temperature Characteristic

Circuit Schematic



Package Dimensions

Dimensions in Millimeters



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